

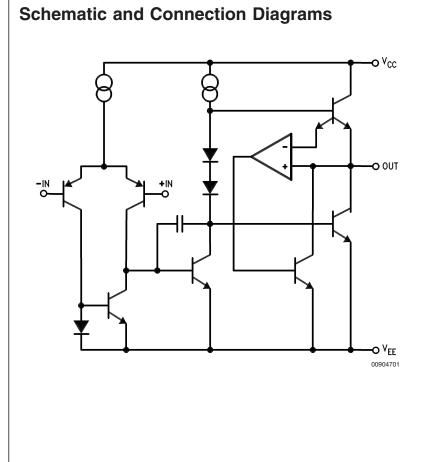
# LM837 Low Noise Quad Operational Amplifier General Description Features

The LM837 is a quad operational amplifier designed for low noise, high speed and wide bandwidth performance. It has a new type of output stage which can drive a 600 $\Omega$  load, making it ideal for almost all digital audio, graphic equalizer, preamplifiers, and professional audio applications. Its high performance characteristics also make it suitable for instrumentation applications where low noise is the key consideration.

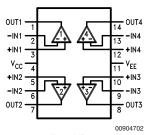
The LM837 is internally compensated for unity gain operation. It is pin compatible with most other standard quad op amps and can therefore be used to upgrade existing systems with little or no change.

- High slew rate 10 V/µs (typ); 8 V/µs (min)
  Wide gain bandwidth product (min)
  Power bandwidth 200 kHz (typ); 15 MHz
  High output current ±40 mA
  Excellent output drive performance >600Ω
- Low input noise voltage
- Low total harmonic distortion
- Low offset voltage
- 200 kHz (typ) ±40 mA >600Ω 4.5 nV/√Hz 0.0015% 0.3 mV

LM837 Low Noise Quad Operational Amplifier



#### Dual-In-Line Package



Top View Order Number LM837M, LM837MX or LM837N See NS Package Number M14A or N14A

#### Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

Supply Voltage, $V_{CC}/V_{EE}$	±18V
Differential Input Voltage, V <sub>ID</sub> (Note 2)	±30V
Common Mode Input Voltage, V <sub>IC</sub>	
(Note 2)	±15V
Power Dissipation, P <sub>D</sub> (Note 3)	1.2W (N)
	830 mW (M)
Operating Temperature Range, T <sub>OPR</sub>	–40°C to +85°C

# DC Electrical Characteristics

 $T_A = 25^{\circ}C, V_S = \pm 15V$ 

Storage Temperature Range, T <sub>STG</sub>	–60°C to +150°C
Soldering Information	
Dual-In-Line Package	
Soldering (10 seconds)	260°C
Small Outline Package	
Vapor Phase (60 seconds)	215°C
Infrared (15 seconds)	220°C
ESD rating to be determined.	
See AN-450 "Surface Mounting Method	ds and Their Effect

See AN-450 "Surface Mounting Methods and Their Effect on Product Reliability" for other methods of soldering surface mount devices.

Symbol	Parameter	Condition	Min	Тур	Max	Units
Vos	Input Offset Voltage	$R_{S} = 50\Omega$		0.3	5	mV
l <sub>os</sub>	Input Offset Current			10	200	nA
I <sub>B</sub>	Input Bias Current			500	1000	nA
A <sub>V</sub>	Large Signal Voltage Gain	$R_L = 2 k\Omega, V_{OUT} = \pm 10V$	90	110		dB
V <sub>OM</sub>	Output Voltage Swing	$R_{L} = 2 k\Omega$	±12	±13.5		V
		$R_{L} = 600\Omega$	±10	±12.5		V
V <sub>CM</sub>	Common Mode Input Voltage		±12	±14.0		V
CMRR	Common Mode Rejection Ratio	$V_{IN} = \pm 12V$	80	100		dB
PSRR	Power Supply Rejection Ratio	V <sub>S</sub> = 15 ~ 5, -15 ~ -5	80	100		dB
I <sub>S</sub>	Power Supply Current	$R_{L} = \infty$ , Four Amps		10	15	mA

### **AC Electrical Characteristics**

 $T_A = 25^{\circ}C, V_S = \pm 15V$ 

Symbol	Parameter	Condition	Min	Тур	Мах	Units
SR	Slew Rate	$R_L = 600\Omega$	8	10		V/µs
GBW	Gain Bandwidth Product	f = 100 kHz, $R_L = 600\Omega$	15	25		MHz

### **Design Electrical Characteristics**

 $T_{A}= 25^{\circ}C, V_{S}=\pm 15V$  (Note 4)

Symbol	Parameter	Condition	Min	Тур	Max	Units
PBW	Power Bandwidth	$V_{O} = 25 V_{P-P}, R_{L} = 600\Omega, THD < 1\%$		200		kHz
e <sub>n1</sub>	Equivalent Input Noise Voltage	JIS A, $R_s = 100\Omega$		0.5		μV
e <sub>n2</sub>	Equivalent Input Noise Voltage	f = 1 kHz				nV/
				4.5		√Hz
i <sub>n</sub> Equivalent Input Noise Cur	Equivalent Input Noise Current	f = 1 kHz		0.7		pA/
						√Hz
THD	Total Harmonic Distortion	$\begin{array}{l} A_V = 1,  V_{OUT} = 3  Vrms, \\ f = 20 \sim 20  kHz,  R_L = 600\Omega \end{array}$		0.0015		%
f <sub>U</sub>	Zero Cross Frequency	Open Loop		12		MHz
φ <sub>m</sub>	Phase Margin	Open Loop		45		deg
	Input-Referred Crosstalk	f = 20 ~ 20 kHz		-120		dB
$\Delta V_{OS} / \Delta T$	Average TC of Input Offset Voltage			2		µV/°C

#### Design Electrical Characteristics (Continued)

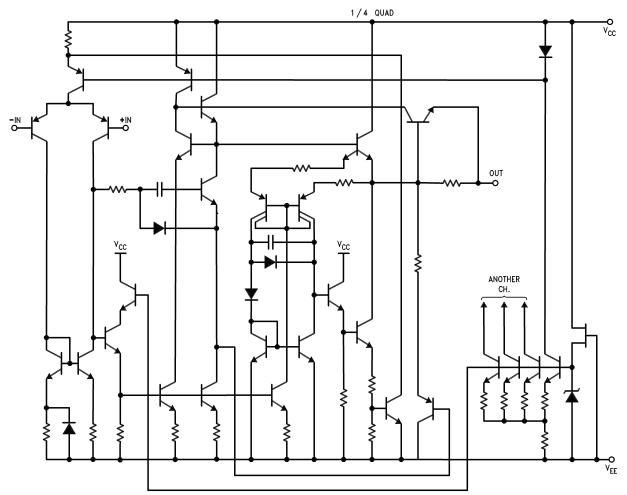
Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which guarantee specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not guaranteed for parameters where no limit is given, however, the typical value is a good indication of device performance.

Note 2: Unless otherwise specified the absolute maximum input voltage is equal to the power supply voltage.

Note 3: For operation at ambient temperatures above 25°C, the device must be derated based on a 150°C maximum junction temperature and a thermal resistance, junction to ambient, as follows: LM837N, 90°C/W; LM837M, 150°C/W.

Note 4: The following parameters are not tested or guaranteed.

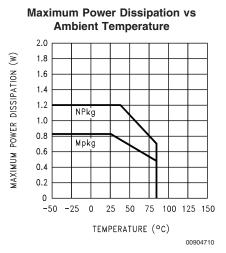
### **Detailed Schematic**



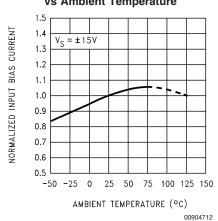
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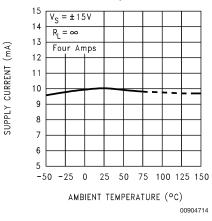
## **Typical Performance Characteristics**

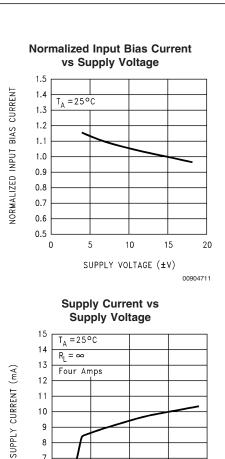


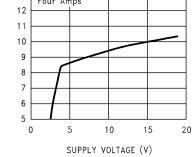
**Normalized Input Bias Current** vs Ambient Temperature



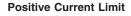


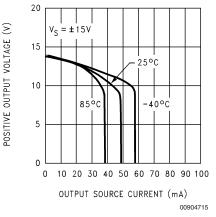


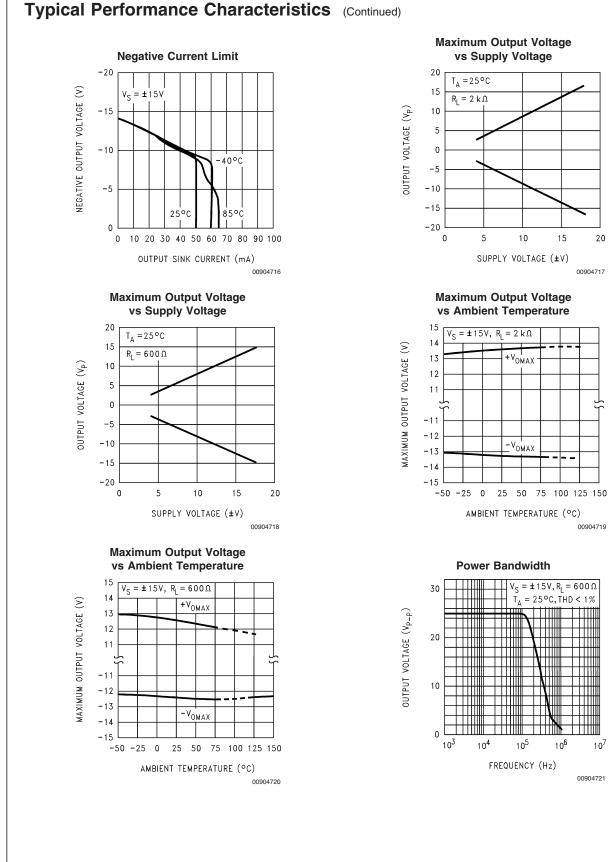


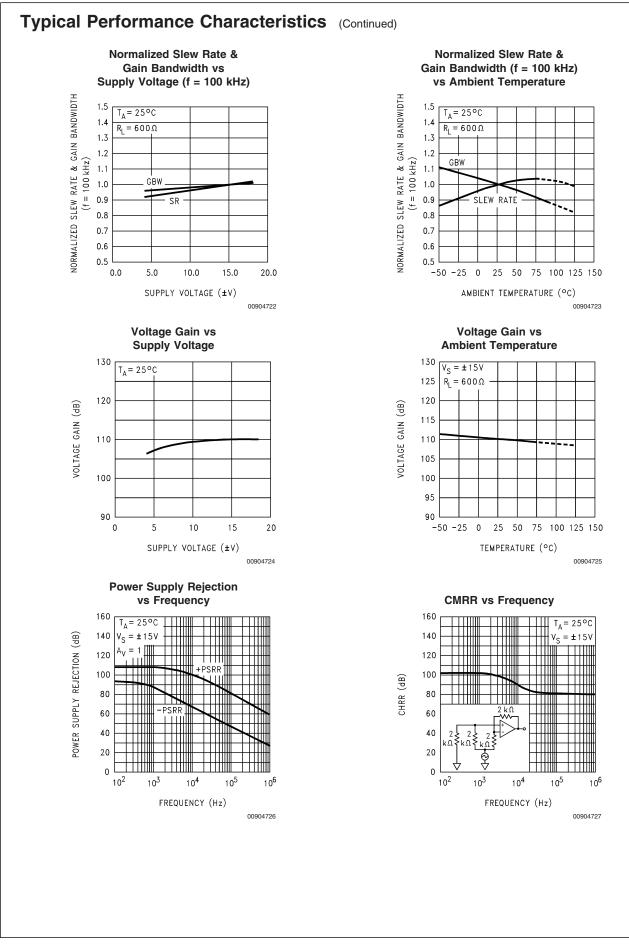


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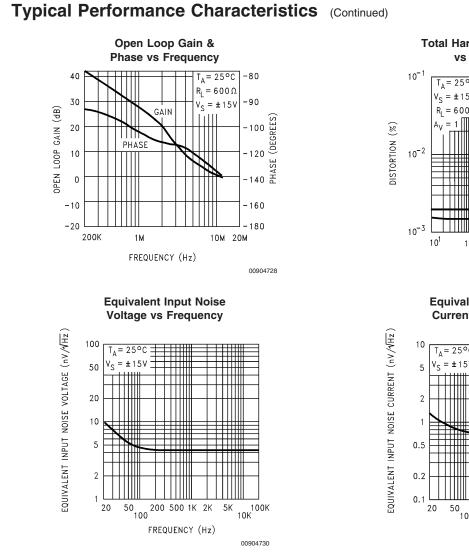




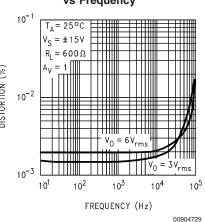




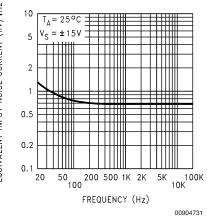
LM837

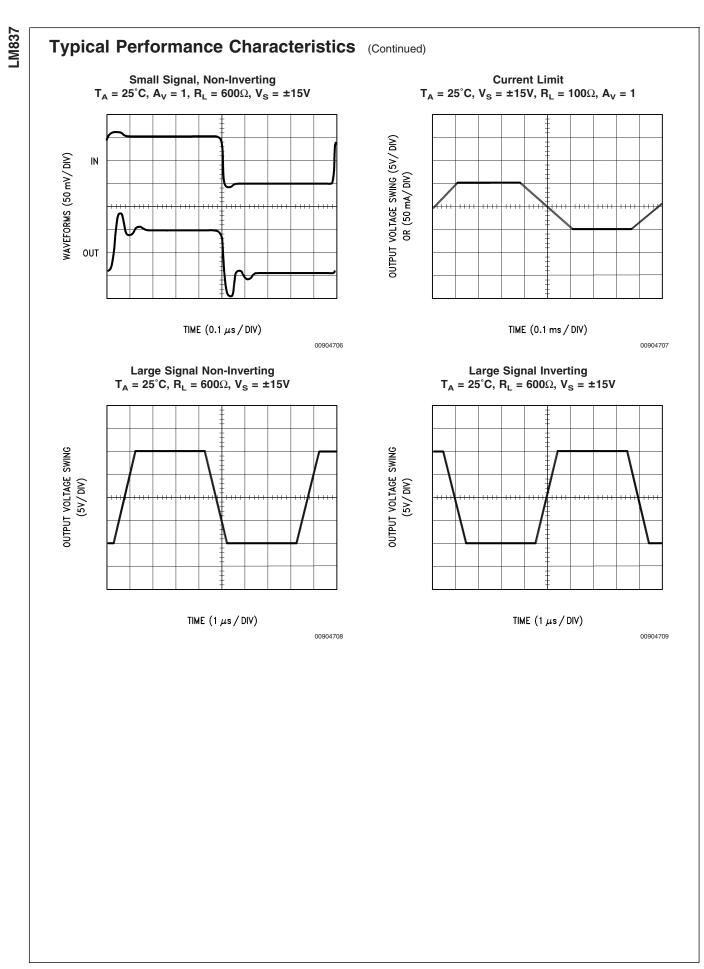


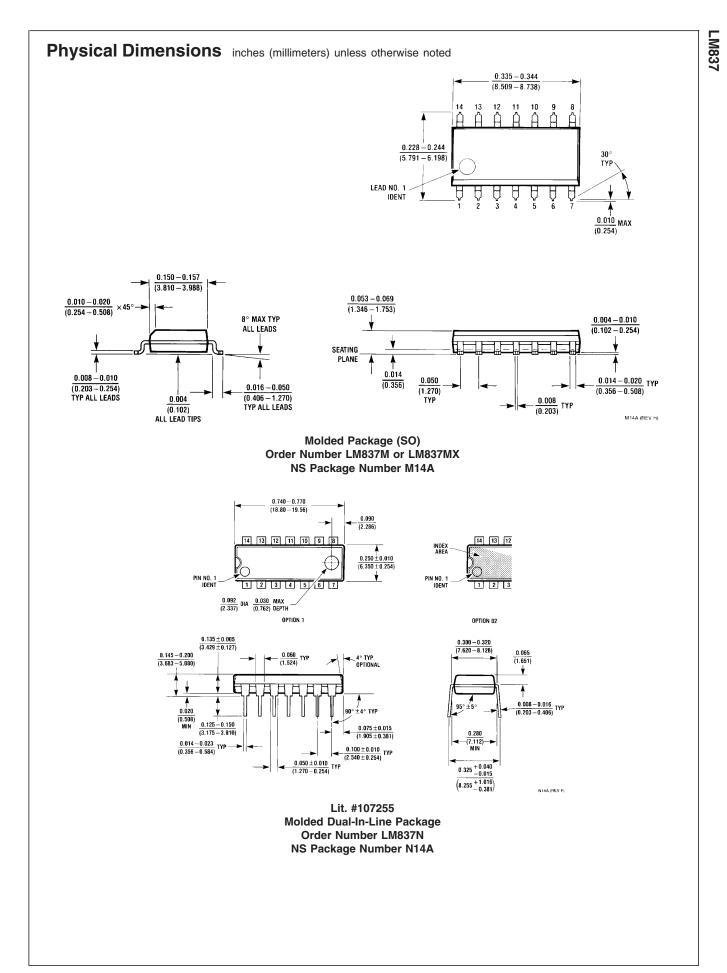
Total Harmonic Distortion vs Frequency



Equivalent Input Noise Current vs Frequency







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**Notes** 

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